EH2720TTS-48.000M



Series -RoHS Compliant (Pb-free) 2.5V 4 Pad 5mm x 7mm Ceramic SMD LVCMOS Oscillator

Gross Leak Test Mechanical Shock

Moisture Resistance

Moisture Sensitivity

Solderability

Vibration

Resistance to Solvents

Temperature Cycling

Resistance to Soldering Heat

Frequency Tolerance/Stability ±20ppm Maximum

- Pin 1 Connection Tri-State (High Impedance)

T TS -48.000M

- Nominal Frequency

48.000MHz

Operating Temperature Range 0°C to +70°C

EH27 20

Duty Cycle 50 ±5(%)

ELECTRICAL SPECIFICATIONS				
48.000MHz				
±20ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°, 260°C Reflow, Shock, and Vibration)				
±5ppm/Year Maximum				
0°C to +70°C				
2.5Vdc ±5%				
7mA Maximum (No Load)				
90% of Vdd Minimum (IOH = -8mA)				
10% of Vdd Maximum (IOL = +8mA)				
6nSec Maximum (Measured at 20% to 80% of waveform)				
50 \pm 5(%) (Measured at 50% of waveform)				
15pF Maximum				
CMOS				
Tri-State (High Impedance)				
90% of Vdd Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output (High Impedance)				
10μA Maximum (Pin 1 = Ground)				
±100pSec Maximum				
10mSec Maximum				
-55°C to +125°C				
ENVIRONMENTAL & MECHANICAL SPECIFICATIONS				
MIL-STD-883, Method 3015, Class 1, HBM: 1500V				
MIL-STD-883, Method 1014, Condition A				
UL94-V0				

MIL-STD-883, Method 1014, Condition C

MIL-STD-883, Method 2002, Condition B

MIL-STD-202, Method 210, Condition K

MIL-STD-883, Method 1010, Condition B

MIL-STD-883, Method 2007, Condition A

MIL-STD-883, Method 1004

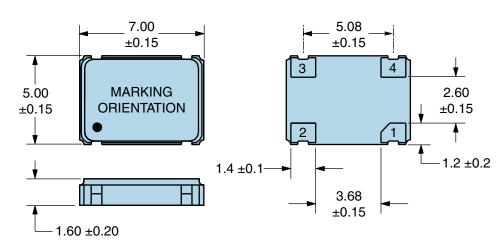
MIL-STD-202, Method 215

MIL-STD-883, Method 2003

J-STD-020, MSL 1

EH2720TTS-48.000M

MECHANICAL DIMENSIONS (all dimensions in millimeters)



ECL	IP1	EK ®
CORP	ORA	TION

PIN	CONNECTION
1	Tri-State
2	Case Ground
3	Output
4	Supply Voltage
LINE	MARKING
LINE	MARKING
LINE 1	MARKING ECLIPTEK
1 2	
1	ECLIPTEK
1 2	ECLIPTEK 48.000M

Suggested Solder Pad Layout

All Dimensions in Millimeters



All Tolerances are ±0.1

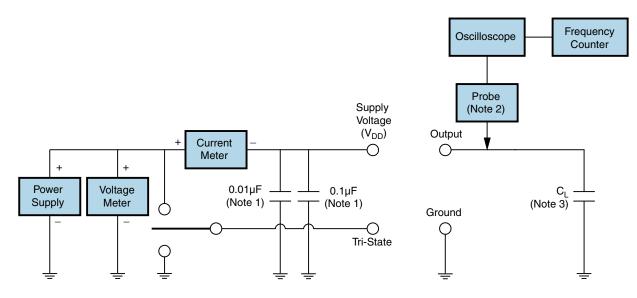
EH2720TTS-48.000M



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output



- Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value C_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

EH2720TTS-48.000M

T _s MAX to T _L (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	150°C
- Temperature Typical (T _s TYP)	175°C
 Temperature Maximum (T_s MAX) 	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T _L to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (t _p)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



Recommended Solder Reflow Methods

EH2720TTS-48.000M



Low Temperature Infrared/Convection 240°C

T_s MAX to T_L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T⊾ to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (t_p)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)